

Silicon Carbide (SiC) MOSFET - 22 mohm, 1200 V, M3, D²PAK-7L

NVBG022N120M3S

Features

- Typ. $R_{DS(on)} = 22 \text{ m}\Omega @ V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge $(Q_{G(tot)} = 148 \text{ nC})$
- High Speed Switching with Low Capacitance (Coss = 148 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- These Devices are RoHS Compliant

Typical Applications

- Automotive On Board Charger
- Automotive DC/DC Converter for EV/HEV
- Automotive Traction Inverter

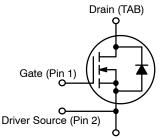
$\textbf{MAXIMUM RATINGS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	1200	V
Gate-to-Source Voltage			V_{GS}	-10/+22	V
Recommended Operation Values of Gate-to-Source Voltage		V_{GSop}	-3/+18	V	
Continuous Drain Current (Note 2)	Steady State	T _C = 25°C	I _D	58	Α
Power Dissipation (Note 2)			P _D	234	W
Continuous Drain Current (Notes 1, 2)	Steady State	T _C = 100°C	I _D	41	Α
Power Dissipation (Notes 1, 2)			P _D	117	W
Pulsed Drain Current (Note 3)	T _C = 25°C		I _{DM}	159	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	ç
Source Current (Body Diode) T _C = 25°C, V _{GS} = -3 V			I _S	53	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 23.1 A, L = 1 mH) (Note 4)			E _{AS}	267	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 10 seconds)			TL	245	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface mounted on a FR-4 board using1 in² pad of 2 oz copper.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. Repetitive rating, limited by max junction temperature.
- 4. Peak current might be limited by transconductance
- 5. EAS of 264 mJ is based on starting T_J = 25°C; L = 1 mH, IAS = 23.1 A, V_{DD} = 100 V, V_{GS} = 18 V.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
1200 V	30 mΩ @ 18 V	58 A



Power Source (Pins 3, 4, 5, 6, 7)

N-CHANNEL MOSFET



D2PAK-7L CASE 418BJ

MARKING DIAGRAM

BG022N 120M3S AYWWZZ

BG022N120M3S = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping
NVBG022N120M3S	D2PAK-7L	800 / Tape & Reel

THERMAL CHARACTERISTICS

Parameter		Тур	Max	Unit
Junction-to-Case - Steady State (Note 2)		0.64	-	°C/W
Junction-to-Ambient - Steady State (Notes 2, 3)		-	40	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
OFF-STATE CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	1200	_	-	V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C	-	0.3	-	V/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 1200 V	_	_	100	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = +22/-10 V, V _{DS} = 0 V	1	_	±1	μΑ	
ON-STATE CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 20 \text{ mA}$	2.04	2.72	4.4	V	
Recommended Gate Voltage	V_{GOP}		-3	-	+18	V	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 18 V, I _D = 40 A, T _J = 25°C	-	22	30	mΩ	
		V _{GS} = 18 V, I _D = 40 A, T _J = 175°C	-	47	-		
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 40 A	-	34	-	S	
CHARGES, CAPACITANCES & GATE RES	SISTANCE			•			
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V	_	3200	-	pF	
Output Capacitance	Coss		-	148	-		
Reverse Transfer Capacitance	C _{RSS}		_	14	-		
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -3/18 \text{ V}, V_{DS} = 800 \text{ V},$ $I_{D} = 40 \text{ A}$	_	20	-	nC	
Total Gate Charge	Q _{G(TOT)}	I _D = 40 A	_	148	-	1	
Gate-to-Source Charge	Q _{GS}		-	35	-		
Gate-to-Drain Charge	Q_{GD}		-	38	-		
Gate-Resistance	R_{G}	f = 1 MHz	_	1.5	_	Ω	
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = -3/18 V$,	_	18	_	ns	
Rise Time	t _r	$V_{DS} = 800 \text{ V},$ $I_{D} = 40 \text{ A},$	_	24	_		
Turn-Off Delay Time	t _{d(OFF)}	$R_G = 4.5 \Omega$ inductive load (Note 6)	_	47	_		
Fall Time	t _f	madeuve ieda (viete e)	_	14	_		
Turn-On Switching Loss	E _{ON}		_	485	-	μJ	
Turn-Off Switching Loss	E _{OFF}		-	220	-		
Total Switching Loss	E _{tot}		_	705	-		
SOURCE-DRAIN DIODE CHARACTERISTICS							
Continuous Source-Drain Diode Forward Current	I _{SD}	V_{GS} = -3 V, T_C = 25°C	-	-	53	А	
Pulsed Source-Drain Diode Forward Current (Note 2)	I _{SDM}		-	-	159		
Forward Diode Voltage	V_{SD}	V _{GS} = -3 V, I _{SD} = 40 A, T _J = 25°C	-	4.5	-	V	

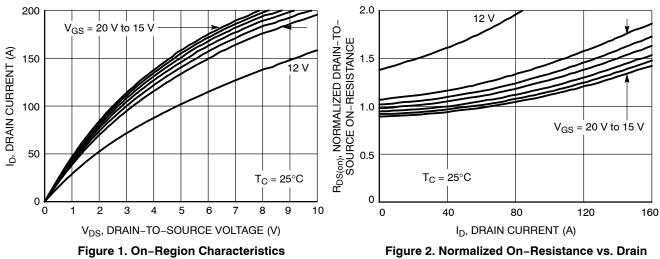
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
SOURCE-DRAIN DIODE CHARACTERISTICS							
Reverse Recovery Time	t _{RR}	$V_{GS} = -3/18 \text{ V}, I_{SD} = 40 \text{ A},$	-	23	-	ns	
Reverse Recovery Charge	Q _{RR}	$dI_{S}/dt = 1000 \text{ A/}\mu\text{s}, V_{DS} = 800 \text{ V}$	_	146	-	nC	
Reverse Recovery Energy	E _{REC}	1	_	5	-	μJ	
Peak Reverse Recovery Current	I _{RRM}	1	_	13	-	Α	
Charge time	t _A		_	13	-	ns	
Discharge time	t _B	1	_	10	-	ns	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. E_{ON}/E_{OFF} result is with body diode

TYPICAL CHARACTERISTICS



Current and Gate Voltage

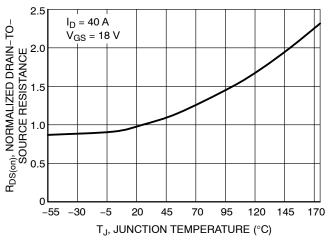


Figure 3. On-Resistance Variation with Temperature

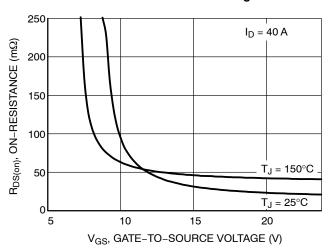


Figure 4. On-Resistance vs. Gate-to-Source Voltage

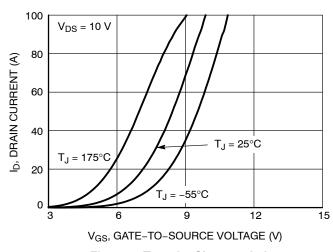


Figure 5. Transfer Characteristics

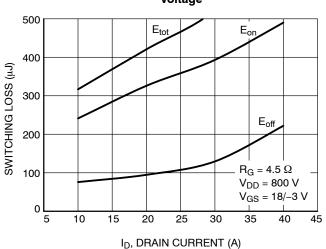


Figure 6. Switching Loss vs. Drain Current

TYPICAL CHARACTERISTICS

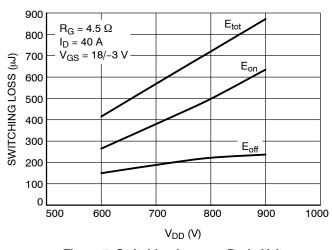


Figure 7. Switching Loss vs. Drain Voltage

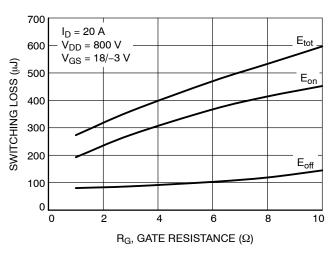


Figure 8. Switching Loss vs. Gate Resistance

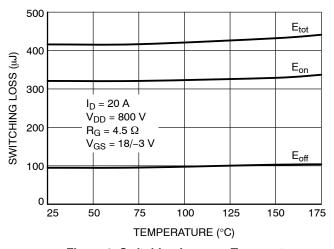


Figure 9. Switching Loss vs. Temperature

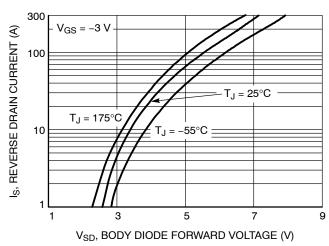
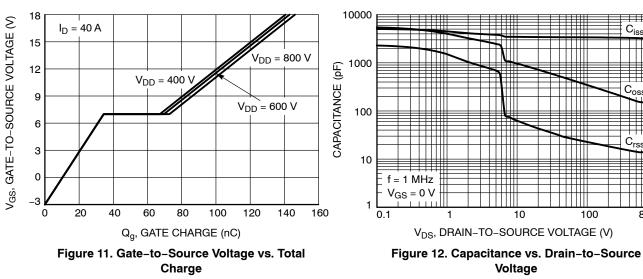
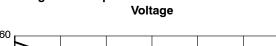


Figure 10. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS





C_{iss}

800

100

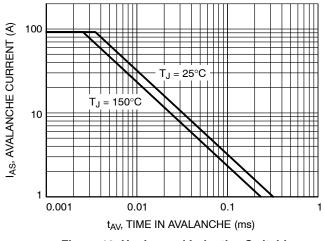


Figure 13. Unclamped Inductive Switching Capability

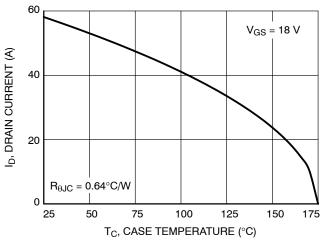


Figure 14. Maximum Continuous Drain **Current vs. Case Temperature**

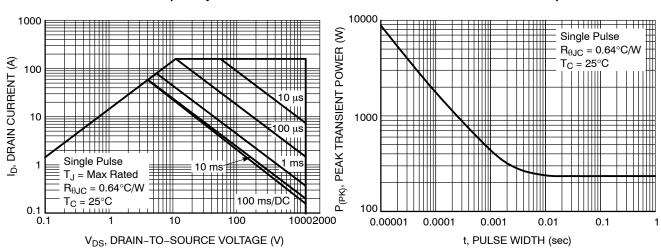


Figure 15. Safe Operating Area

Figure 16. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

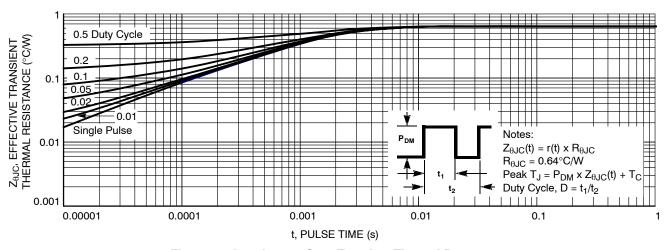


Figure 17. Junction-to-Case Transient Thermal Response

D²PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**

DATE 16 AUG 2019

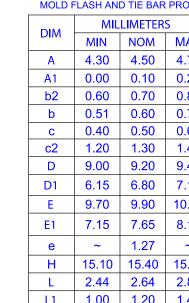
NOTES:

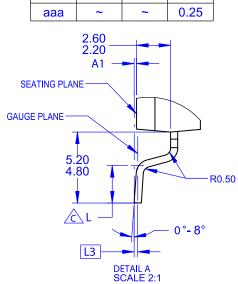
- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- OUT OF JEDEC STANDARD VALUE.

 D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.

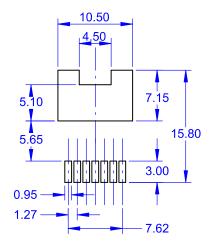
 E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		

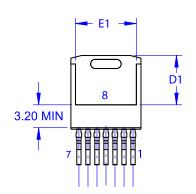




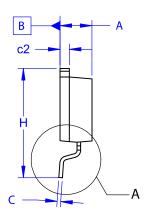
A E -	L1
D	1
1	
b2 — -	
e b -	_



LAND PATTERN RECOMMENDATION



⊕ | aaa | B | A | M)



GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to

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DESCRIPTION:	D ² PAK7 (TO-263-7L HV)		PAGE 1 OF 1	

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